# **SIEMENS**

# IL420 600 V TRIAC DRIVER OPTOCOUPLER

# **FEATURES**

- High Input Sensitivity IFT=2 mA
- . Blocking Voltage, 600 V
- 300 mA On-State Current
- High Static dv/dt 10,000 V/μs
- Inverse Parallel SCRs Provide Commutating dv/dt >2K V/μs
- Very Low Leakage <10 μA
- Isolation Test Voltage from Double Molded Package 5300 VAC<sub>RMS</sub>
- Small 6-Pin DIP Package
- Underwriters Lab File #E52744
- VDE 0884 Available with Option 1

# **Maximum Ratings**

#### **Emitter**

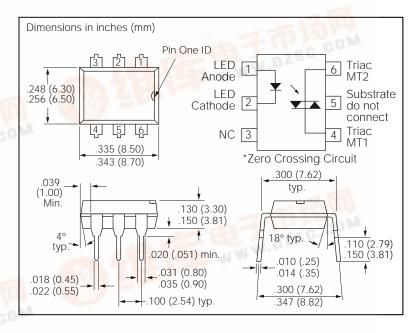
Reverse Voltage	6 V
Forward Current	
Surge Current	2.5 A
Power Dissipation	100 mW
Derate from 25°C	
Thermal Resistance	750 °C/W

# Detector

Peak Off-State Voltage	600 V
Peak Reverse Voltage	600 V
RMS On-State Current	300 mA
Single Cycle Surge	3 A
Total Power Dissipation	500 mW
Derate from 25°C	6.6 mW/°C
Thermal Resistance	150°C/W

# **Package**

Storage Temperature	-55°C to +150°C
Operating Temperature	-55°C to +100°C
Lead Soldering Temperature	260°C/5 sec.
Isolation Test Voltage	5300 VAC <sub>RMS</sub>



# **DESCRIPTION**

The IL420 consists of a GaAs IRLED optically coupled to a photosensitive non-zero crossing TRIAC network. The TRIAC consists of two inverse parallel connected monolithic SCRs. These three semiconductors are assembled in a six pin 0.3 inch dual in-line package, using high insulation double molded, over/under leadframe construction.

High input sensitivity is achieved by using an emitter follower phototransistor and a cascaded SCR predriver resulting in an LED trigger current of less than 2 mA (DC).

The IL420 uses two discrete SCRs resulting in a commutating dV/dt of greater than 10KV/ms. The use of a proprietary *dv/dt clamp* results in a static dV/dt of greater than 10KV/ms. This clamp circuit has a MOSFET that is enhanced when high dV/dt spikes occur between MT1 and MT2 of the TRIAC. When conducting, the FET clamps the base of the phototransistor, disabling the first stage SCR predriver.

The 600 V blocking voltage permits control of off-line voltages up to 240 VAC, with a safety factor of more than two, and is sufficient for as much as 380 VAC.

The IL420 isolates low-voltage logic from 120, 240, and 380 VAC lines to control resistive, inductive, or capacitive loads including motors, solenoids, high current thyristors or TRIAC and relays.

Applications include solid-state relays, industrial controls, office equipment, and consumer appliances.



# Characteristics

	Symbol	Min	Тур	Max	Unit	Condition
Emitter						
Forward Voltage	V <sub>F</sub>		1.16	1.35	V	I <sub>F</sub> =10 mA
Reverse Current	I <sub>R</sub>		0.1	10	μА	V <sub>R</sub> =6 V
Capacitance	Co		40		pF	V <sub>F</sub> =0 V, f=1 MHz
Thermal Resistance, Junction to Lead	R <sub>THJL</sub>		750		°C/W	
Output Detector						
Off-State Voltage	V <sub>D (RMS)</sub>	424	460		V	I <sub>D(RMS)</sub> =70 μA
Reverse Voltage	V <sub>R</sub>	424	460		V	I <sub>R(RMS)</sub> =70 μA
Off-State Current	I <sub>D (RMS)</sub>		10	100	μА	V <sub>D</sub> =600 V, T <sub>A</sub> =100°C
Reverse Current	I <sub>R (RMS)</sub>		10	100	μА	V <sub>R</sub> =600 V, T <sub>A</sub> =100°C
On-State Voltage	V <sub>TM</sub>		1.7	3	V	I <sub>T</sub> =300 mA
On-State Current	I <sub>TM</sub>			300	mA	PF=1.0, V <sub>T(RMS)</sub> =1.7 V
Surge (Non-Repititive) On-State Current	I <sub>TSM</sub>			3	А	f=50 Hz
Holding Current	I <sub>H</sub>		65	500	μА	
Latching Current	IL		5		mA	V <sub>T</sub> =2.2 V
LED Trigger Current	I <sub>FT</sub>		1	2	mA	V <sub>AK</sub> =5 V
Turn-On Time	t <sub>ON</sub>		35		μs	V <sub>RM</sub> =V <sub>DM</sub> =424 VAC
Turn-Off Time	t <sub>OFF</sub>		50		μs	PF=1.0, I <sub>T</sub> =300 mA
Critical State of Rise of Off-State Voltage	dv/dt <sub>cr</sub>	10000 5000			V/μs V/μs	V <sub>D</sub> =0.67 V <sub>DRM</sub> T <sub>i</sub> =25°C TJ=80°C
Critical Rate of Rise of Voltage at Current Commutation	dv/dt <sub>crq</sub> dv/dt <sub>crq</sub>	10000 5000			V/µs V/µs	V <sub>D</sub> =0.67 V <sub>DRM</sub> , di/dt <sub>crq</sub> ≤15 A/ms Tj=25°C T <sub>j</sub> =80°C
Critical State of Rise of On-State Current	di/dt <sub>cr</sub>			8	A/µs	
Thermal Resistance, Junction to Lead	R <sub>THJL</sub>		150		°C/W	
Insulation and Isolation						
Critical Rate of Rise of Coupled Input/Output Voltage	dv <sub>(IO)</sub> /dt		5000		V/µs	I <sub>T</sub> =0 A, V <sub>RM</sub> =V <sub>DM</sub> =424 VAC
Common Mode Coupling Capacitor	C <sub>CM</sub>		0.01		pF	
Package Capacitance	C <sub>IO</sub>		0.8		pF	f=1 MHz, V <sub>IO</sub> =0 V
Isolation Test Voltage, Input-Output	V <sub>ISO</sub>	5300			VAC <sub>RMS</sub>	Relative Humidity ≤50%
Creepage		≥7			mm	
Clearance		≥7			mm	
Creepage Tracking Resistance per DIN IEC 112/VDE 0303, Part 1 group IIIa per DIN VDE 0110		СТІ		175		
Isolation Resistance	R <sub>is</sub> R <sub>is</sub>		≥10 <sup>12</sup> ≥10 <sup>11</sup>		ΩΩ	V <sub>IO</sub> =500, T <sub>A</sub> =25°C V <sub>IO</sub> =500, T <sub>A</sub> =100°C
Trigger Current Temperature Gradient	$\Delta I_{FT}/\Delta T_{j}$		7	14	μΑ/Κ	
Capacitance Between Input and Output Circuit	C <sub>IO</sub>			2	pF	V <sub>R</sub> =0, f=1 kHz

IL420

Figure 1. Forward voltage versus forward current

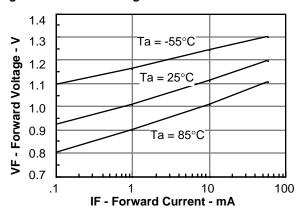


Figure 2. Peak LED current versus duty factor, Tau

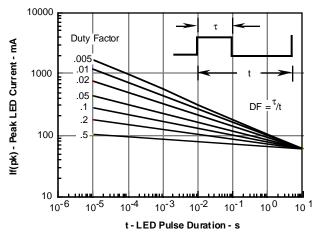


Figure 3. Maximum LED power dissipation

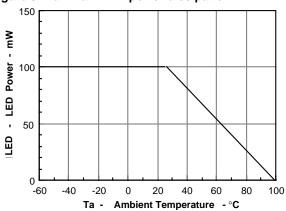


Figure 4. Typical output characteristics

 $I_T=f(V_t)$ , parameter:  $T_i$ SICO0002  $I_T$   $I_T$ 

Figure 5. Current reduction

 $I_{TRMS}$ =f(T<sub>A</sub>) R<sub>thJA</sub>=125 K/W Device switch is soldered in PCB or base plate

**-** *V*<sub>T</sub>

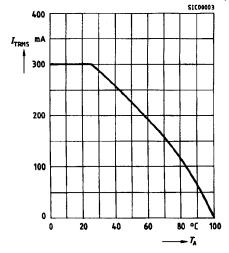


Figure 6. Current reduction

I<sub>TRMS</sub>=f(T<sub>PIN5</sub>), R<sub>thJ</sub>=16.5 K/W Thermocouple measurement must be performed potentially separated to A1 and A2. Measuring junction to be as near as possible at case.

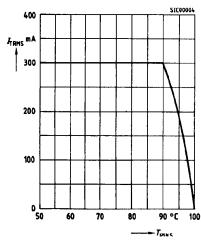


Figure 7. Typical trigger delay time  $tgd=f(I_F/I_{FT25^{\circ}C})$ ,  $V_D=200$  V, parameter:  $T_i$ 

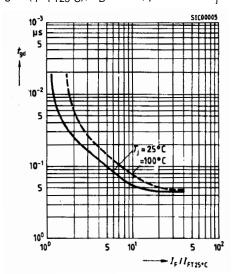


Figure 8. Typical off-state current  $I_D=f(T_j)$ ,  $V_D=800$  V, parameter:  $T_j$ 

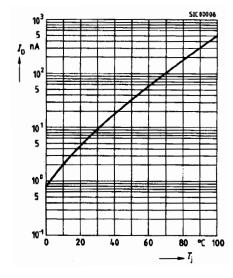


Figure 9. Power dissipation

for 40 to 60 Hz line operation,  $P_{TOT}$ = $f(I_{TRMS})$ 

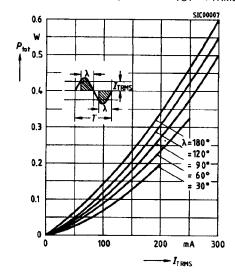


Figure 10. Pulse trigger current

 $I_{FTN}$ =f(t<sub>pIF</sub>) $I_{FTN}$  normalized to  $I_{FT}$ , referring to  $t_{pIF}$  $\geq$ 1ms,  $V_{OP}$ =200 V, f=40 to 60 Hz typ.

